Notice of References Cited Application/Control No. 10/054,505 Examiner Reexamination FLANERY, PATRICK Art Unit Rajesh Khattar Applicant(s)/Patent Under Reexamination FLANERY, PATRICK Page 1 of 1

U.S. PATENT DOCUMENTS.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0074277	04-2003	Foutz, Gregory L.	705/26
*	В	US-2001/0044774	11-2001	Sasazawa et al.	705/39
*	С	US-2002/0022982	02-2002	Cooperstone et al.	705/7
*	D	US-2002/0143682	10-2002	Bergmann et al.	705/36
*	E	US-2002/0178039	11-2002	Kennedy, Diane M.	705/7
*	F	US-5,839,118	11-1998	Ryan et al.	705/36R
*	G	US-2002/0143682	10-2002	Bergmann et al.	705/36
*	Н	US-5,926,792	07-1999	Koppes et al.	705/4
*	ı	US-6,571,219	05-2003	Spivey, Loehr H.	705/36R
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				•	
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	Р	•				
	Q					
	R		,	•		·
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Limited Liability Company, and Spotlight on Limited Liability Company; www.corporate.com
	V	Difference between an LLC and a S Corporation; www.corporate.com
	w	Limited Liability Company 101; www.about.com
	x	Rabbi Trust and Nonqualified Plan Types; http://en.wikipedia.org/wiki/Rabbi_trust and www.finance.cch.com/text/c40s10d390.asp

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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